



SEMITRANS® 2

High Speed IGBT4 Modules

SKM100GAR12F4

Features*

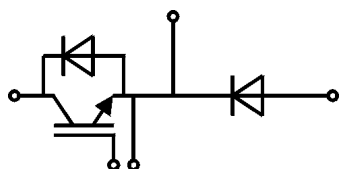
- High speed trench and field-stop IGBT
- CAL4 ultra-fast = soft switching 4. generation CAL-diode
- Insulated copper baseplate using DBC technology (Direct Bonded Copper)
- Increased power cycling capability
- For higher switching frequencies above 15kHz
- UL recognized, file no. E63532

Typical Applications

- Electronic welders
- DC/DC – converter
- Brake chopper
- Switched reluctance motor

Remarks

- Case temperature limited to $T_c = 125^\circ\text{C}$ max.
- Recommended $T_{op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for $T_j = 150^\circ\text{C}$



GAR

Absolute Maximum Ratings

Symbol	Conditions		Values	Unit
IGBT				
V _{CES}	T _j = 25 °C		1200	V
I _C	T _j = 175 °C	T _c = 25 °C	153	A
		T _c = 80 °C	117	A
I _{Cnom}			100	A
I _{CRM}	I _{CRM} = 2 x I _{Cnom}		200	A
V _{GES}			-20 ... 20	V
t _{psc}	V _{CC} = 800 V V _{GE} ≤ 15 V V _{CES} ≤ 1200 V	T _j = 150 °C	10	µs
T _j			-40 ... 175	°C
Inverse diode				
V _{RRM}	T _j = 25 °C		1200	V
I _F	T _j = 175 °C	T _c = 25 °C	111	A
		T _c = 80 °C	82	A
I _{Fnom}			100	A
I _{FRM}	I _{FRM} = 2xI _{Fnom}		200	A
I _{FSM}	t _p = 10 ms, sin 180°, T _j = 25 °C		550	A
T _j			-40 ... 175	°C
Freewheeling diode				
V _{RRM}	T _j = 25 °C		1200	V
I _F	T _j = 175 °C	T _c = 25 °C	111	A
		T _c = 80 °C	82	A
I _{Fnom}			100	A
I _{FRM}	I _{FRM} = 2xI _{Fnom}		200	A
I _{FSM}	t _p = 10 ms, sin 180°, T _j = 25 °C		550	A
T _j			-40 ... 175	°C
Module				
I _{t(RMS)}			200	A
T _{stg}	module without TIM		-40 ... 125	°C
V _{isol}	AC sinus 50 Hz, t = 1 min		4000	V

Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
IGBT					
$V_{CE(sat)}$	$I_C = 100\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	2.05	2.38	V
		$T_j = 150^\circ\text{C}$	2.55	2.93	V
V_{CE0}	chipelevel	$T_j = 25^\circ\text{C}$	1.10	1.28	V
		$T_j = 150^\circ\text{C}$	0.95	1.13	V
r_{CE}	$V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	9.5	11	$\text{m}\Omega$
		$T_j = 150^\circ\text{C}$	16	18	$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 3.8\text{ mA}$	5.1	5.8	6.4	V
I_{CES}	$V_{GE} = 0\text{ V}$ $V_{CE} = 1200\text{ V}$	$T_j = 25^\circ\text{C}$		1	mA
		$T_j = 150^\circ\text{C}$	-		mA
C_{ies}	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	6.2		nF
C_{oes}	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	0.41		nF
C_{res}	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	0.35		nF
Q_G	$V_{GE} = -8\text{ V} \dots +15\text{ V}$		567		nC
R_{Gint}	$T_j = 25^\circ\text{C}$		0		Ω



SEMITRANS® 2

High Speed IGBT4 Modules

SKM100GAR12F4

Features*

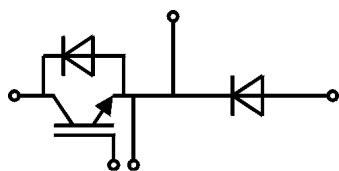
- High speed trench and field-stop IGBT
- CAL4 ultra-fast = soft switching 4. generation CAL-diode
- Insulated copper baseplate using DBC technology (Direct Bonded Copper)
- Increased power cycling capability
- For higher switching frequencies above 15kHz
- UL recognized, file no. E63532

Typical Applications

- Electronic welders
- DC/DC – converter
- Brake chopper
- Switched reluctance motor

Remarks

- Case temperature limited to $T_c = 125^\circ\text{C}$ max.
- Recommended $T_{op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for $T_j = 150^\circ\text{C}$



GAR

Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
$t_{d(on)}$	$V_{CC} = 600\text{ V}$ $I_C = 100\text{ A}$ $T_j = 150^\circ\text{C}$		12		ns
t_r	$V_{GE} = +15/-15\text{ V}$ $R_{G\ on} = 3.9\ \Omega$ $T_j = 150^\circ\text{C}$		20		ns
E_{on}	$R_{G\ off} = 3.9\ \Omega$ $T_j = 150^\circ\text{C}$		6.6		mJ
$t_{d(off)}$	$dI/dt_{on} = 5000\text{ A}/\mu\text{s}$ $T_j = 150^\circ\text{C}$		315		ns
t_f	$dI/dt_{off} = 1300\text{ A}/\mu\text{s}$ $T_j = 150^\circ\text{C}$		65		ns
E_{off}	$dV/dt = 4300\text{ V}/\mu\text{s}$ $L_s = 26\text{ nH}$ $T_j = 150^\circ\text{C}$		8		mJ
$R_{th(j-c)}$	per IGBT			0.238	K/W
$R_{th(c-s)}$	per IGBT ($\lambda_{grease}=0.81\text{ W}/(\text{m}^2\text{K})$)		0.122		K/W

Inverse diode

$V_F = V_{EC}$	$I_F = 100\text{ A}$ $V_{GE} = 0\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	2.55 2.46	2.93 2.80	V
V_{F0}	chipelevel	$T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	1.51 1.16	1.75 1.40	V
r_F	chipelevel	$T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	10 13	12 14	m Ω
I_{RRM}	$I_F = 100\text{ A}$ $dI/dt_{off} = 5000\text{ A}/\mu\text{s}$ $T_j = 150^\circ\text{C}$	$T_j = 150^\circ\text{C}$	200		A
Q_{rr}	$V_{GE} = -15\text{ V}$ $T_j = 150^\circ\text{C}$	$T_j = 150^\circ\text{C}$	16.5		μC
E_{rr}	$V_{CC} = 600\text{ V}$ $T_j = 150^\circ\text{C}$	$T_j = 150^\circ\text{C}$	6.3		mJ
$R_{th(j-c)}$	per diode			0.483	K/W
$R_{th(c-s)}$	per diode ($\lambda_{grease}=0.81\text{ W}/(\text{m}^2\text{K})$)		0.134		K/W

Freewheeling diode

$V_F = V_{EC}$	$I_F = 100\text{ A}$ $V_{GE} = 0\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	2.55 2.46	2.93 2.80	V
V_{F0}	chipelevel	$T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	1.51 1.16	1.75 1.40	V
r_F	chipelevel	$T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	10 13	12 14	m Ω
I_{RRM}	$I_F = 100\text{ A}$ $dI/dt_{off} = 5000\text{ A}/\mu\text{s}$ $T_j = 150^\circ\text{C}$	$T_j = 150^\circ\text{C}$	200		A
Q_{rr}	$V_{GE} = -15\text{ V}$ $T_j = 150^\circ\text{C}$	$T_j = 150^\circ\text{C}$	16.5		μC
E_{rr}	$V_{CC} = 600\text{ V}$ $T_j = 150^\circ\text{C}$	$T_j = 150^\circ\text{C}$	6.3		mJ
$R_{th(j-c)}$	per diode			0.483	K/W
$R_{th(c-s)}$	per diode ($\lambda_{grease}=0.81\text{ W}/(\text{m}^2\text{K})$)		0.134		K/W

Module

L_{CE}			30		nH
$R_{CC'+EE'}$	measured per switch	$T_C = 25^\circ\text{C}$ $T_C = 125^\circ\text{C}$	0.65 1.09		m Ω
$R_{th(c-s)1}$	calculated without thermal coupling ($\lambda_{grease}=0.81\text{ W}/(\text{m}^2\text{K})$)		0.0639		K/W
$R_{th(c-s)2}$	including thermal coupling, T_s underneath module ($\lambda_{grease}=0.81\text{ W}/(\text{m}^2\text{K})$)		0.071		K/W
M_s	to heat sink M6		3	5	Nm
M_t		to terminals M5	2.5	5	Nm
					Nm
w				160	g

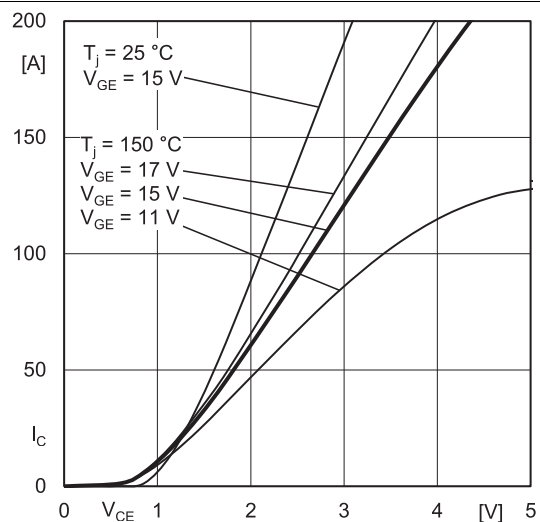


Fig. 1: Typ. output characteristic, inclusive $R_{CC} + EE'$

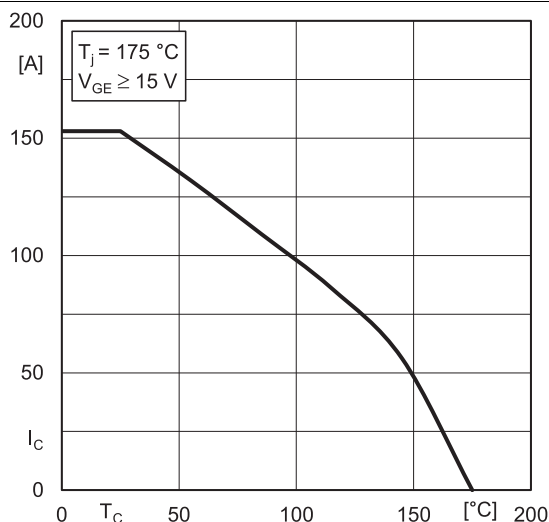


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

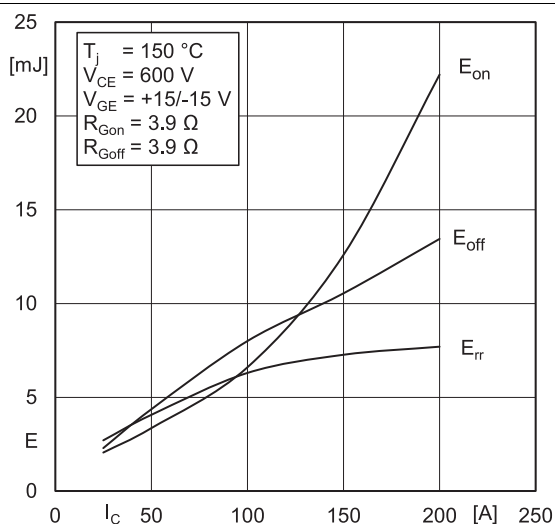


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

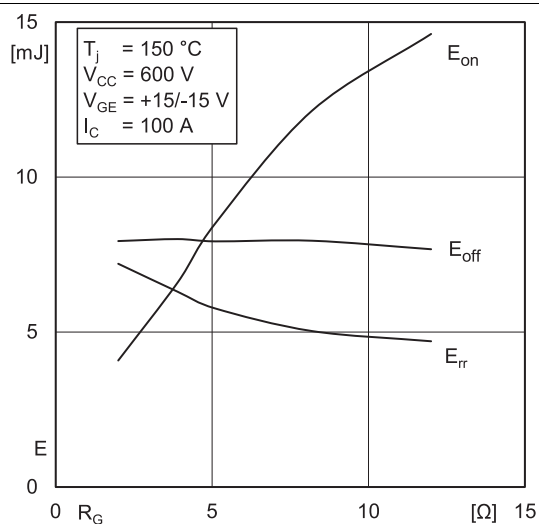


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

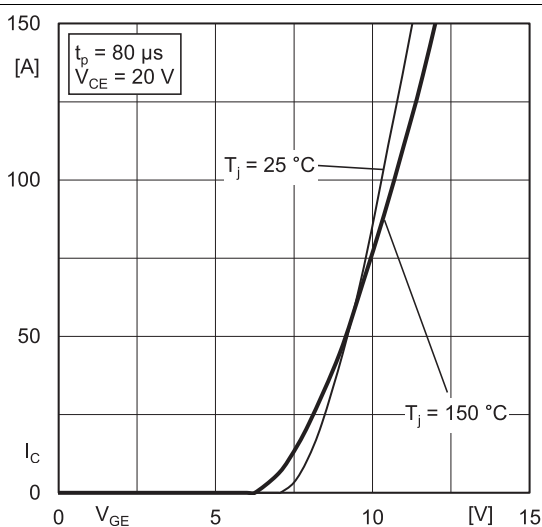


Fig. 5: Typ. transfer characteristic

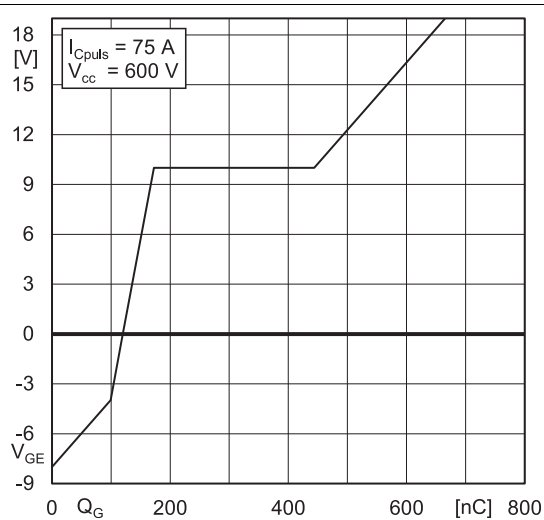


Fig. 6: Typ. gate charge characteristic

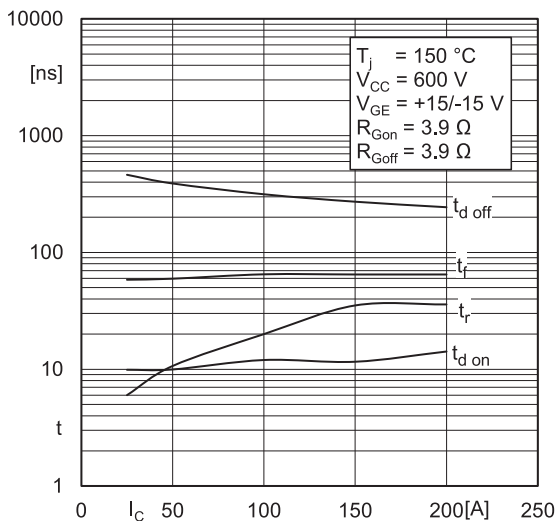


Fig. 7: Typ. switching times vs. I_C

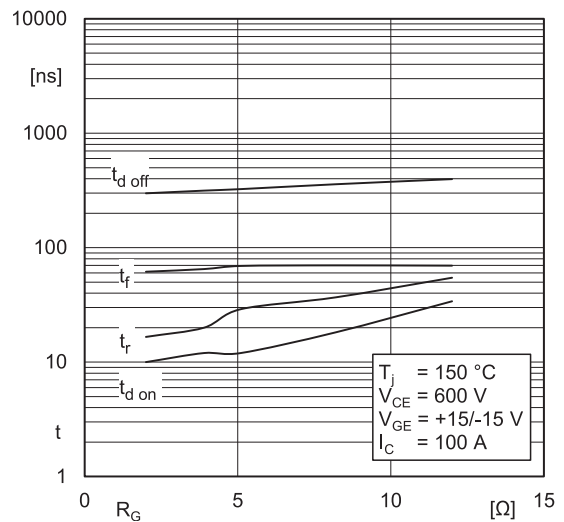


Fig. 8: Typ. switching times vs. gate resistor R_G

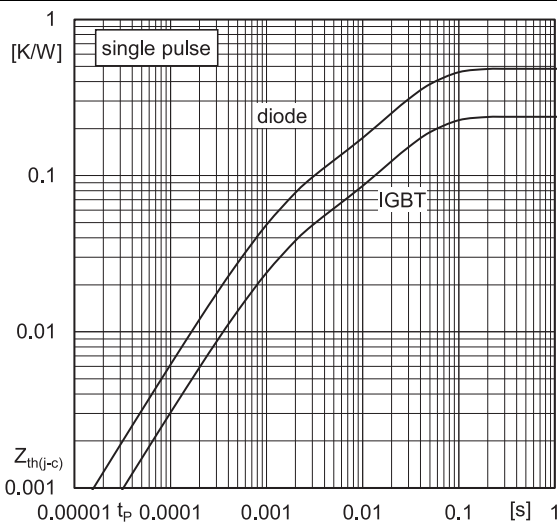


Fig. 9: Transient thermal impedance

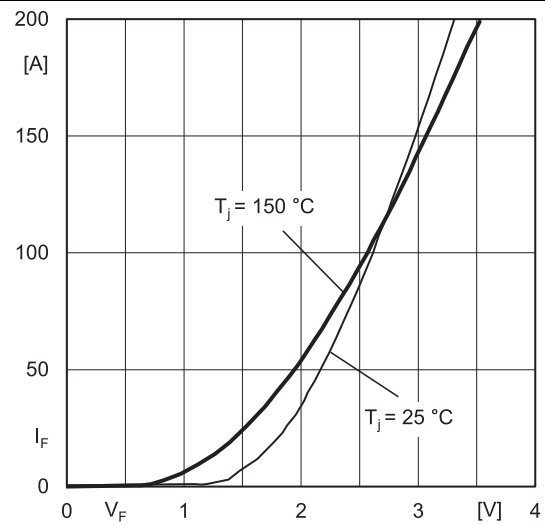


Fig. 10: Typ. CAL diode forward charact., incl. $R_{CC'+EE'}$

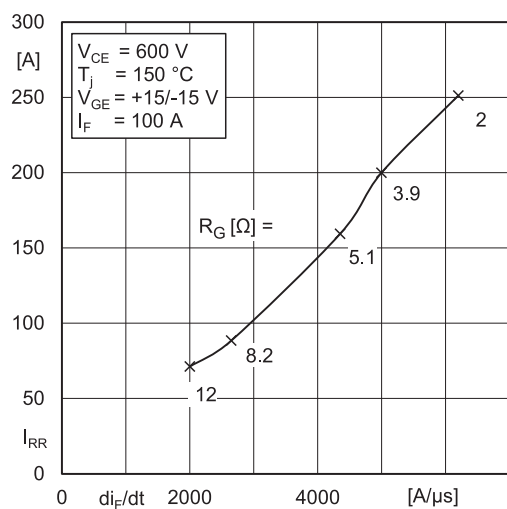


Fig. 11: Typ. CAL diode peak reverse recovery current

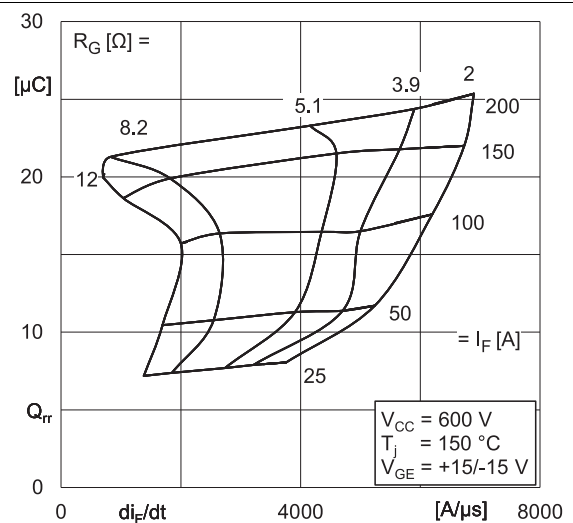
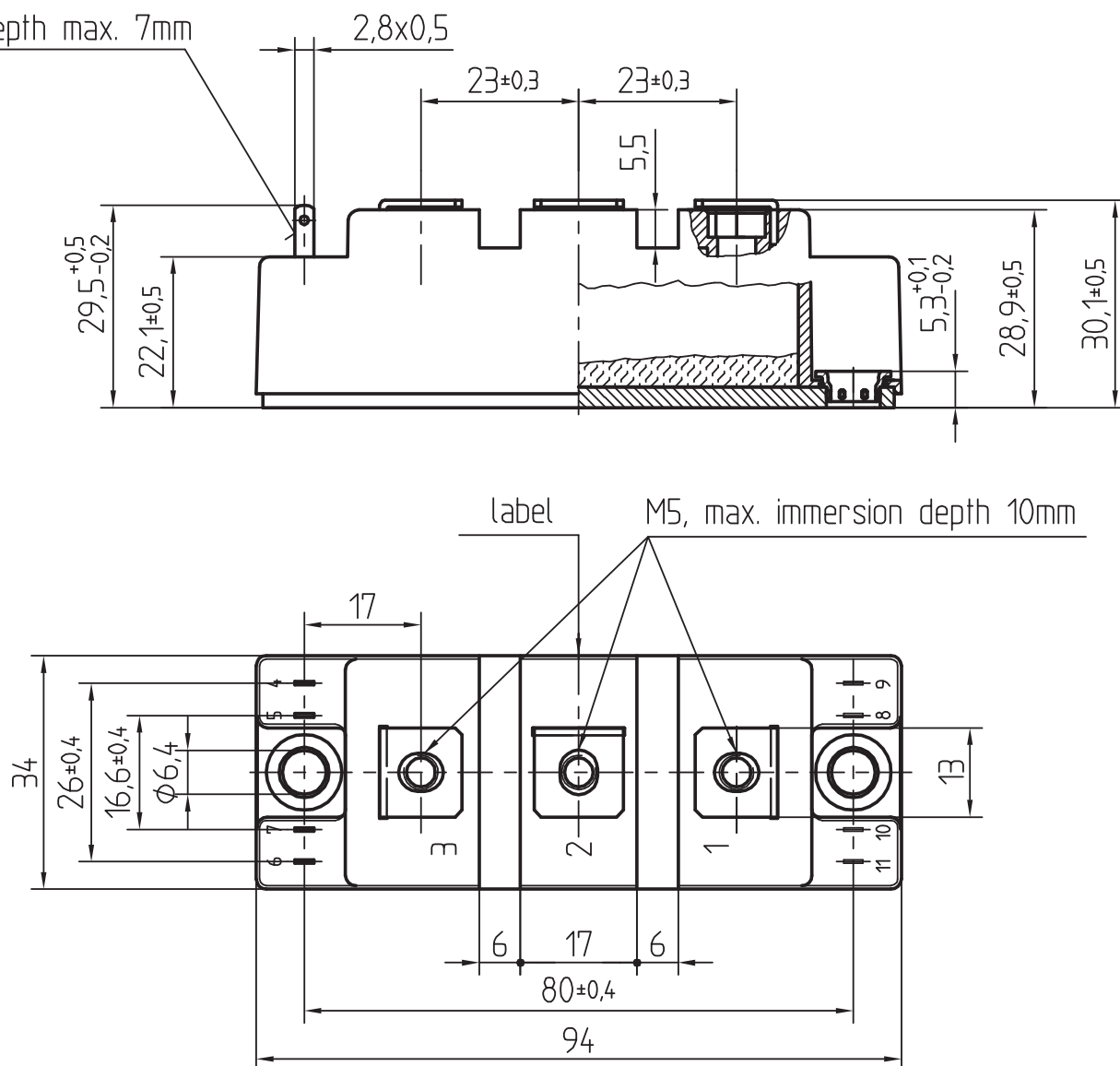


Fig. 12: Typ. CAL diode peak reverse recovery charge

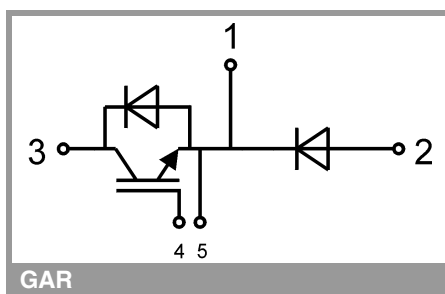
Dimensions in mm

Plug in depth max. 7mm



General tolerance $\pm 0,5$ mm

SEMITRANS 2



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

***IMPORTANT INFORMATION AND WARNINGS**

The specifications of SEMIKRON products may not be considered as guarantee or assurance of product characteristics ("Beschaffenheitsgarantie"). The specifications of SEMIKRON products describe only the usual characteristics of products to be expected in typical applications, which may still vary depending on the specific application. Therefore, products must be tested for the respective application in advance. Application adjustments may be necessary. The user of SEMIKRON products is responsible for the safety of their applications embedding SEMIKRON products and must take adequate safety measures to prevent the applications from causing a physical injury, fire or other problem if any of SEMIKRON products become faulty. The user is responsible to make sure that the application design is compliant with all applicable laws, regulations, norms and standards. Except as otherwise explicitly approved by SEMIKRON in a written document signed by authorized representatives of SEMIKRON, SEMIKRON products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury. No representation or warranty is given and no liability is assumed with respect to the accuracy, completeness and/or use of any information herein, including without limitation, warranties of non-infringement of intellectual property rights of any third party. SEMIKRON does not assume any liability arising out of the applications or use of any product; neither does it convey any license under its patent rights, copyrights, trade secrets or other intellectual property rights, nor the rights of others. SEMIKRON makes no representation or warranty of non-infringement or alleged non-infringement of intellectual property rights of any third party which may arise from applications. Due to technical requirements our products may contain dangerous substances. For information on the types in question please contact the nearest SEMIKRON sales office. This document supersedes and replaces all information previously supplied and may be superseded by updates. SEMIKRON reserves the right to make changes.